

Notice of References Cited	Application/Control No. 10/754,571	Applicant(s)/Patent Under Reexamination YAMAGUCHI ET AL.	
	Examiner James Turchen	Art Unit 2139	Page 1 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0018736	08-2001	Hashimoto et al.	713/1
*	B	US-2004/0123132	06-2004	Montgomery et al.	713/200
*	C	US-2003/0196102	10-2003	McCarroll, William M.	713/194
*	D	US-7,036,017	04-2006	Gammel et al.	713/189
*	E	US-6,993,654	01-2006	Seki et al.	713/172
*	F	US-6,993,130	01-2006	Fernandez et al.	380/46
*	G	US-6,965,977	11-2005	Yi, Kyung-Suk	711/169
*	H	US-6,523,118	02-2003	Buer, Mark Leonard	713/189
*	I	US-6,175,924	01-2001	Arnold, Todd Weston	713/189
*	J	US-5,224,166	06-1993	Hartman, Jr., Robert C.	713/190
*	K	US-2004/0093505	05-2004	Hatakeyama et al.	713/189
*	L	US-2002/0138722	09-2002	Douceur et al.	713/153
*	M	US-5,943,421	08-1999	Grabon, Robert J.	380/269

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/754,571		Applicant(s)/Patent Under Reexamination YAMAGUCHI ET AL.	
	Examiner James Turchen		Art Unit 2139	Page 2 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,895,506	05-2005	Abu-Husein, Loay	713/193
*	B	US-2003/0126458	07-2003	Teramoto et al.	713/194
*	C	US-2005/0071651	03-2005	Aguilar et al.	713/189
*	D	US-2002/0191793	12-2002	Anand et al.	380/255
*	E	US-5,825,878	10-1998	Takahashi et al.	713/190
*	F	US-2004/0117639	06-2004	Mowery, Keith R.	713/187
*	G	US-2002/0051536	05-2002	Shirakawa et al.	380/45
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.